

N THE UNITED STATES PATENT AND TRADEMARK OFFICE

In re application of

Attn: APPLICATION BRANCH

Mitsuo TADA et al.

Attorney Docket No. 2003 1149

Serial No. NEW

Filed August 13, 2003

FREQUENCY MEASURING DEVICE, POLISHING DEVICE USING THE SAME AND EDDY CURRENT SENSOR (Rule 1.53(b) Divisional of Serial No. 09/982,025, Filed October 19, 2001) THE COMMISSIONER IS AUTHORIZED TO CHARGE ANY DEFICIENCY IN THE FEES FOR THIS PAPER TO DEPOSIT ACCOUNT NO. 23-0975

SUBMISSION OF CORRECTED FORM PTO-1449

Commissioner for Patents
P.O. Box 1450
Alexandria, VA 22313-1450

Sir:

Submitted herewith is a corrected PTO Form-1449 to correctly identify Document AB listed on the PTO Form-1449 filed on August 13, 2003 as U.S. Patent No. 5,644,221 to Li et al. Document AB listed on the August 13, 2003 PTO Form-1449 was incorrectly listed as U.S. Patent No. 5,664,221 to Li et al. A copy of U.S. Patent No. 5,644,221 was submitted with an Information Disclosure Statement and Form PTO-1449 filed on August 13, 2003 for prior parent application Serial No. 09/982,025. Also submitted herewith is a copy of the August 13, 2003 PTO-Form 1449 with the correction of Document AB made thereon in red.

Respectfully submitted,

Mitsuo TADA et al.

By_

Jonathan R. Bowser Registration No. 54,574 Attorney for Applicants

JRB(NEP)/edg Washington, D.C. 20006-1021 Telephone (202) 721-8200 Facsimile (202) 721-8250 September 24, 2003

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PATENT AND TRADEMARK OFFICE TRADE				APPLICANT Mitsuo TADA et al.							
(Use several sheets if necessary) Date Submitted to PTO: September 24, 2003				FILING DATE August 13, 2003			GROUP				
U.S. PATENT DOCUMENTS											
*EXAMINER INITIAL		DOCUMENT NUMBER	DATE	NAME	CLA	ASS	SUBCLASS	FILING DATE IF APPROPRIATE			
	AA	5,559,428	9-1996	Li et al.							
	AB	5,644,221	7-1997	Li et al.							
	AC	5,659,492	8-1997	Li et al.							
	AD	5,660,672	8-1997	Li et al.			75	50			
	AE	5,663,637	9-1997	Li et al.			,087	らら) .1		
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<u>\</u>	AG	6,563,308 5-200		Nagano et al.				100 E			
	АН	2002-0055192	5-2002	Redeker et al.			3				
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			FORE	IGN PATENT DOCUMENTS				<u>.</u>			
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^{*}EXAMINER: Initial if reference considered, whether or not citation is in conformance with MPEP 609; Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.

Sheet 1 of 1		,					· -	,		
FORM PTO 1449 (modified SEP 2 1 2003 U.S. DEPARTMENT OF COMMERCE PATENT AND TRADEMARK OFFICE LIST OF REFERENCES CITED BY APPLICANT(S)					ATTY DOCKET NO. SERIAL NEW		NO.			
				APPLICANT Mitsuo TADA et al.						
(Use several sheets if necessary) Date Submitted to PTO: August 13, 2003				FILING DATE August 13, 2003			GROUP			
			U.S	S. PATENT DO	CUMENTS					
*EXAMINER INITIAL		DOCUMENT NUMBER	DATE		NAME CLASS SUBCLASS			FILING DATE IF APPROPRIATE		
	АА	5,559,428	9-1996	Li	et al.					
	АВ	5,644,221 5,664,221	7-1997	Li	et al.					
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	AD	5,660,672	8-1997	Li	et al.					
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		DOCUMENT NUMBER	DATE	cc	DUNTRY	CLASS	SUBCLASS	TRANSLA YES	TION NO	
	AJ	JP 60000369 A	1/1985	J	Japan			abstract		
	AK									
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OTHER DOCUMENT(S) (Including Author, Title, Date, Pertinent Pages, Etc.)										
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